

06/04/01

250	307
Class	Subclass

ISSUE CLASSIFICATION

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PATENT NUMBER

U.S. UTILITY Patent Application

O.I.P.E.

PATENT DATE

U.I.P.E.
KS NS 3 Q.A. MT

APPLICATION NO. 09/871739	'CONT/PRIOR F	CLASS 250	SUBCLASS. 200 307	ART UNIT 2878 2853	EXAMINER MONTT
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APPLICANTS:

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Isao Nagaoki
Hiroyuki Kobayashi

TIME

Method and device for observing a specimen in a field of view of an electron microscope

PTO-2040
12/89

ISSUING CLASSIFICATION									
ORIGINAL			CROSS REFERENCE(S)						
CLASS		SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
250		307	250	311					
INTERNATIONAL CLASSIFICATION									
G	O	I	N	23/00					

☐ Continued on Issue Slip Inside File Jacket

☐ TERMINAL
DISCLAIM

☐ The term of this p
subsequent to _____
has been disclaimed.

☐ The term of this patent shall not extend beyond the term of U.S. Patent No. _____

☐ The terminal _____
this patent have been

DRAWINGS			CLAIMS ALLOWED	
Sheets Drwg. 16	Figs. Drwg. 24	Print Fig. 1	Total Claims 36	Print Claim for O.G. 1
<u>Reina M. Hall</u> (Assistant Examiner)			NOTICE OF ALLOWANCE MAILED <u>5/01/04</u>	
<u>[Signature]</u> (Primary Examiner)			ISSUE FEE Amount Due <u>\$1620.</u> Date Paid	
<u>[Signature]</u> (Legal Instruments Examiner)			ISSUE BATCH NUMBER	

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